

FUJITSU

CMOS UV ERASABLE 524288-BIT READ ONLY MEMORY

MBM27C512-15 MBM27C512-17

October 1987
Edition 1.0

CMOS 524288 BIT UV ERASABLE AND ELECTRICALLY PROGRAMMABLE READ ONLY MEMORY

The Fujitsu MBM 27C512 is a high speed 524,288 bit static CMOS erasable and electrically reprogrammable read only memory (EPROM). It is especially well suited for application where rapid turn-around and/or bit pattern experimentation, and low-power consumption are important.

A 28-pin dual-in line package with a transparent lid and 32-Pad Leadless Chip Carrier (LCC) are used to package the MBM 27C512. The transparent lid allows the user to expose the device to ultraviolet light in order to erase the memory bit pattern previously programmed. At the completion of erasure, a new pattern can then be written into the memory.

The MBM 27C512 is fabricated using CMOS double polysilicon gate technology with single transistor stacked gate cells. It is organized as 65,536 words by 8 bits for use in microprocessor applications. Single +5V operation greatly facilitates its use in systems.

This specification is applied to "HW" version.

- CMOS power consumption
Standby: 550 μ W/max.
Active: 220mW/max.
- 65,536 words x 8 bits organization, fully decoded
- Single location programming
- Programmable utilizing the Quick Pro™ Algorithm
- No clocks required (fully static operation)
- TTL compatible inputs/outputs
- Fast access time:
150ns max. (MBM27C512-15)
170ns max. (MBM27C512-17)
- Three-state output with OR-tie capability
- Output Enable (\overline{OE}) pin for simplified memory expansion
- Single +5V supply, $\pm 10\%$ tolerance
- Standard 28-pin Ceramic DIP: (Suffix: -Z)
- Standard 32-pad Ceramic LCC: (Suffix: -TV)

ABSOLUTE MAXIMUM RATINGS (See NOTE)

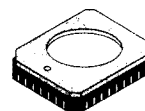
Rating	Symbol	Value	Unit
Temperature under Bias	T_{BIAS}	-25 to +85	$^{\circ}$ C
Storage Temperature	T_{STG}	-65 to +125	$^{\circ}$ C
All Inputs/Outputs Voltage with Respect to GND	V_{IN}, V_{OUT}	-0.6 to $V_{CC} + 0.6$	V
Voltage on A_9 with Respect to GND	V_{A9}	-0.6 to 13.5	V
V_{PP} Voltage with Respect to GND	V_{PP}	-0.6 to +14	V
Supply Voltage with Respect to GND	V_{CC}	-0.6 to +7	V

NOTE: Permanent device damage may occur if ABSOLUTE MAXIMUM RATINGS are exceeded. Functional operation should be restricted to the conditions as detailed in the operational sections of this data sheet. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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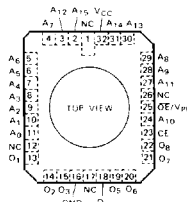
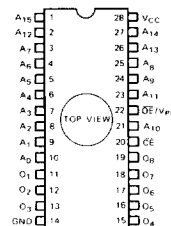


CERAMIC PACKAGE
DIP-28C-C01



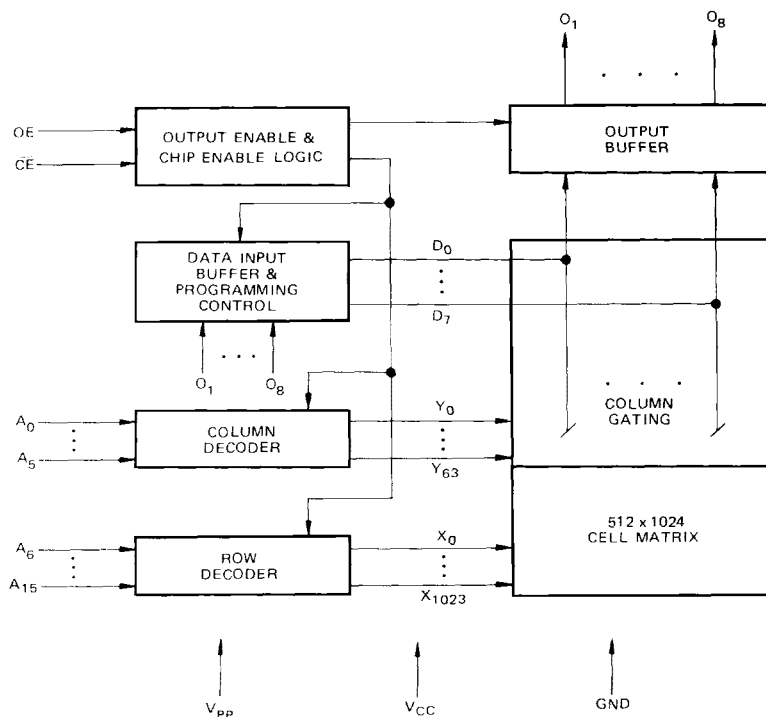
CERAMIC PACKAGE
LCC-32C-F01

PIN ASSIGNMENT



This device contains circuitry to protect the inputs against damage due to high static voltages or electric fields. However, it is advised that normal precautions be taken to avoid application of any voltage higher than maximum rated voltages to this high impedance circuit.

Fig. 1 – MBM 27C512 BLOCK DIAGRAM



CAPACITANCE ($T_A = 25^\circ\text{C}$, $f = 1\text{MHz}$)

Parameter	Symbol	Value			Unit
		Min	Typ	Max	
Input Capacitance ($V_{IN} = 0\text{ V}$, except \overline{OE}/V_{PP})	C_{IN1}	—	4	6	pF
\overline{OE}/V_{PP} Input Capacitance ($V_{IN} = 0\text{ V}$)	C_{IN2}	—	—	20	pF
Output Capacitance ($V_{OUT} = 0\text{ V}$)	C_{OUT}	—	8	12	pF

FUNCTIONS AND PIN CONNECTIONS

Function (Pin No.) Mode	Address Input (1~10, 21, 23~27)	Data I/O (11~13, 15~19)	\overline{CE} (20)	\overline{OE}/V_{PP} (22)	V_{CC} (28)	GND (14)
Read	A_{IN}	D_{OUT}	V_{IL}	V_{IL}	5V	GND
Output Disable	A_{IN}	High-Z	V_{IL}	V_{IH}	5V	GND
Standby	Don't Care	High-Z	V_{IH}	Don't Care	5V	GND
Program	A_{IN}	D_{IN}	V_{IL}	12.5V	6V	GND
Program Verify	A_{IN}	D_{OUT}	V_{IL}	V_{IL}	6V	GND
Program Inhibit	Don't Care	High-Z	V_{IH}	12.5V	6V	GND

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RECOMMENDED OPERATING CONDITIONS (Referenced to GND)

Parameter	Symbol	Value			Unit
		Min	Typ	Max	
V_{CC} Supply Voltage	V_{CC}	4.5	5.0	5.5	V
Input High Voltage	V_{IH}	2.0		$V_{CC} + 0.3$	V
Input Low Voltage	V_{IL}	-0.1		0.8	V
Operating Temperature	T_A	0		70	°C

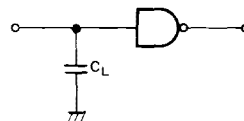
DC CHARACTERISTICS (Recommended operating conditions unless otherwise noted)

Parameter	Symbol	Value			Unit
		Min	Typ	Max	
Input Load Current ($V_{IN} = 5.5$ V)	$ I_{LI} $			10	μ A
Output Leakage Current ($V_{OUT} = 5.5$ V)	$ I_{LO} $			10	μ A
V_{CC} Standby Current ($\overline{CE} = V_{IH}$)	I_{SB1}			1	mA
V_{CC} Standby Current ($\overline{CE} = V_{CC} \pm 0.3$ V, $I_{OUT} = 0$ mA)	I_{SB2}		1	100	μ A
V_{CC} Active Current ($\overline{CE} = V_{IL}$, $I_{OUT} = 0$ mA)	150 ns	I_{CC1}	4	40	mA
	170 ns			30	
V_{CC} Operation Current ($f = 4$ MHz, $I_{OUT} = 0$ mA)	I_{CC2}		10	40	mA
Output Low Voltage ($I_{OL} = 2.1$ mA)	V_{OL}			0.45	V
Output High Voltage ($I_{OH} = -400$ μ A)	V_{OH1}	2.4			V
Output High Voltage ($I_{OH} = -100$ μ A)	V_{OH2}	$V_{CC} - 0.7$			V



Fig. 2 – AC TEST CONDITIONS (INCLUDING PROGRAMMING)

Input Pulse Levels: 0.45V to 2.4V
Input Rise and Fall Times: $\leq 20\text{ns}$
Timing Measurement Reference Levels: 0.8V and 2.0V for inputs
0.8V and 2.0V for outputs
Output Load: 1 TTL gate and $C_L = 100\text{pF}$



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AC CHARACTERISTICS

(Recommended operating conditions unless otherwise noted)

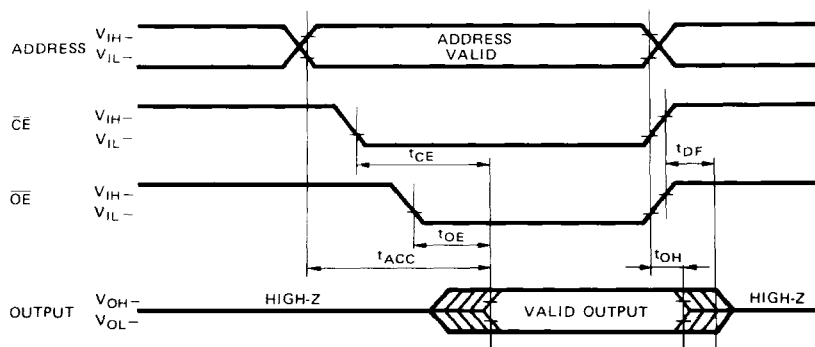
Parameter	Symbol	MBM 27C512-15			MBM 27C512-17			Unit
		Min	Typ	Max	Min	Typ	Max	
Address Access Time*1	t_{ACC}			150			170	ns
$\overline{\text{CE}}$ to Output Delay	t_{CE}			150			170	ns
$\overline{\text{OE}}$ to Output Delay*1	t_{OE}			60			70	ns
Address to Output Hold	t_{OH}	0			0			ns
Output Enable High to Output Float*2	t_{DF}	0		60	0		60	ns

Notes: *1 $\overline{\text{OE}}$ may be delayed up to $t_{\text{ACC}} - t_{\text{OE}}$ after the falling edge of $\overline{\text{CE}}$ without impact on t_{ACC} .

*2 t_{DF} is specified from $\overline{\text{OE}}$ or $\overline{\text{CE}}$, whichever occurs first.

Output Float is defined as the point where data is no longer driven.

OPERATION TIMING DIAGRAM



PROGRAMMING/ERASING INFORMATION

PROGRAMMING

Upon delivery from Fujitsu, or after each erasure (see Erasure section), the MBM 27C512 has all 524,288 bits in the "1", or high state. "0's" are loaded into the MBM 27C512 through the procedure of programming.

The MBM 27C512 is programmed with a fast programming algorithm designed by Fujitsu called Quick Pro™. The programming mode is entered when +12.5V and +6V are applied to V_{PP} and V_{CC} respectively, and \overline{CE} is V_{IH} . A 0.1 μ F capacitor between V_{PP} and GND is needed to prevent excessive voltage transients which could damage the device. The address to be programmed is applied to the proper address pins. The 8 bit data pattern to be written is placed on the respective data output pins. The voltage levels should be standard TTL levels. When both the address and data are stable, a 1 ms programming

pulse is applied to \overline{CE} and after that one additional pulse which is 3 times as wide as previous pulse is applied to \overline{CE} to accomplish the programming.

Procedure of Quick Pro™ (Refer to the attached flowchart.)

- 1) Set the start address (=G) at the address pins.
- 2) Set $V_{CC} = 6V$, $V_{PP} = 12.5V$ and $\overline{CE} = V_{IH}$.
- 3) Clear the programming pulse counter ($X \leftarrow 0$).
- 4) Input data to respective pins.
- 5) Apply ONE programming pulse ($t_{PW} = 1ms$ Typ.) to \overline{CE} .
- 6) Increment the counter ($X \leftarrow X+1$).
- 7) Compare the number (=X) of applied programming pulse with 25 and then verify the programmed data. If programmed data is verified, go to the next step regardless of X value. If $X = 25$ and programmed data is not verified, the

device fails. If $X < 25$ and programmed data is not verified, go back to the step 5).

- 8) Apply one additional wide programming pulse to \overline{CE} (3X ms).
- 9) Compare the address with an end address (=N). If the programmed address is the end address, proceed to the next step. If not, increment the address ($G \leftarrow G+1$) and then go to the step 3) for the next address.
- 10) Set $V_{CC} = V_{PP} = 5V$.
- 11) Verify the all programmed data. If the verification succeeds, the programming completes. If any programmed data is not the same as original data, the device fails.

A continuous TTL low level should not apply to \overline{CE} input pin during the program mode ($V_{PP} = 12.5V$ and $V_{CC} = 6V$) because it is required that one programming pulse width does not exceed 78.75 ms at each address.

ERASURE

In order to clear all locations of their programmed contents, it is necessary to expose the MBM 27C512 to an ultraviolet light source. A dosage of 15 W-seconds/cm² is required to completely erase an MBM 27C512. This dosage can be obtained by exposure to an ultraviolet lamp (wavelength of 2537 Angstroms (Å)) with intensity of 12000 μ W/cm² for 15 to 21 minutes.

The MBM 27C512 should be about one inch from the source and all filters should be removed from the UV light source prior to erasure.

It is important to note that the MBM 27C512 and similar devices, will erase with light sources having wavelengths shorter than 4000Å. Although erasure time will be much longer than

with UV source at 2537Å, nevertheless the exposure to fluorescent light and sunlight will eventually erase the MBM 27C512, and exposure to them should be prevented to realize maximum system reliability. If used in such an environment, the package windows should be covered by an opaque label or substance.

ELECTRONIC SIGNATURE

The MBM 27C512 has electronic signature mode which is intended for use by programming equipment for the purpose of automatically matching the device to be programmed with its cor-

responding programming algorithm.

The electronic signature is activated when +12V is applied to address line A_9 (pin 24) of the MBM 27C512. Two identifier bytes are read out from the

outputs by toggling address line A_0 (pin 10) from V_{IL} to V_{IH} . The address lines from A_1 to A_{13} must be hold at V_{IL} to keep the electronic signature mode. See the table below.

A_0	O_1	O_2	O_3	O_4	O_5	O_6	O_7	O_8	Definition
V_{IL}	0	0	1	0	0	0	0	0	Manufacture
V_{IH}	1	1	0	0	0	1	1	1	Device

Note: $A_9 = 12V \pm 0.5V$

A_1 thru $A_8 = A_{10}$ thru $A_{13} = \overline{CE} = \overline{OE} = V_{IL}$.

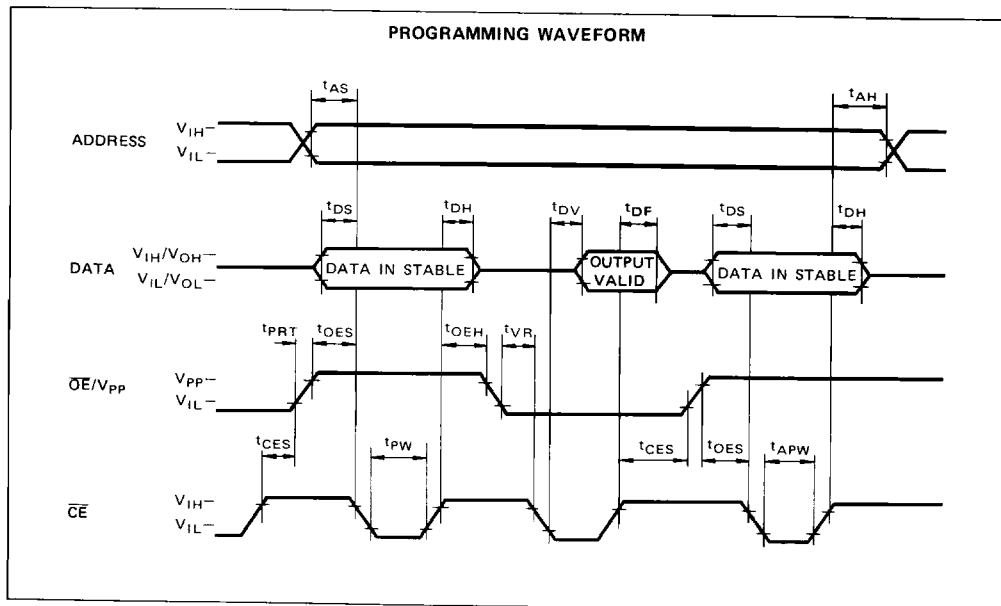
$A_{14} = A_{15} = \text{Either } V_{IL} \text{ or } V_{IH}$

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PROGRAMMING/ERASING INFORMATION (Cont'd)

PROGRAMMING WAVEFORM



DC CHARACTERISTICS

($T_A = 25 \pm 5^\circ\text{C}$, $V_{CC}^{*1} = 6\text{V} \pm 0.25\text{V}$, $V_{PP}^{*2} = 12.5\text{V} \pm 0.3\text{V}$)

Parameter	Symbol	Value			Unit
		Min	Typ	Max	
Input Leakage Current ($V_{IN} = 5.25\text{ V}/0.45\text{ V}$)	$ I_{LI} $			10	μA
V_{PP} Supply Current During Programming Pulse ($\overline{CE} = V_{IL}$)	I_{PP}			50	mA
V_{CC} Supply Current	I_{CC}			30	mA
Input Low Level	V_{IL}	-0.1		0.8	V
Input High Level	V_{IH}	2.0		$V_{CC} + 0.3$	V
Output Low Voltage During Verify ($I_{OL} = 2.1\text{ mA}$)	V_{OL}			0.45	V
Output High Voltage During Verify ($I_{OH} = -400\text{ }\mu\text{A}$)	V_{OH}	2.4			V

Note: *1 V_{CC} must be applied either coincidently or before V_{PP} and removed either coincidently or after V_{PP} .

*2 V_{PP} must not be greater than 14 volts including overshoot. Permanent device damage may occur if the device is taken out or put into socket remaining $V_{PP} = 12.5$ volts. Also, during $\overline{CE} = V_{IL}$, V_{PP} must not be switched from 5 to 12.5 volts or vice-versa.



PROGRAMMING/ERASING INFORMATION (Cont'd)

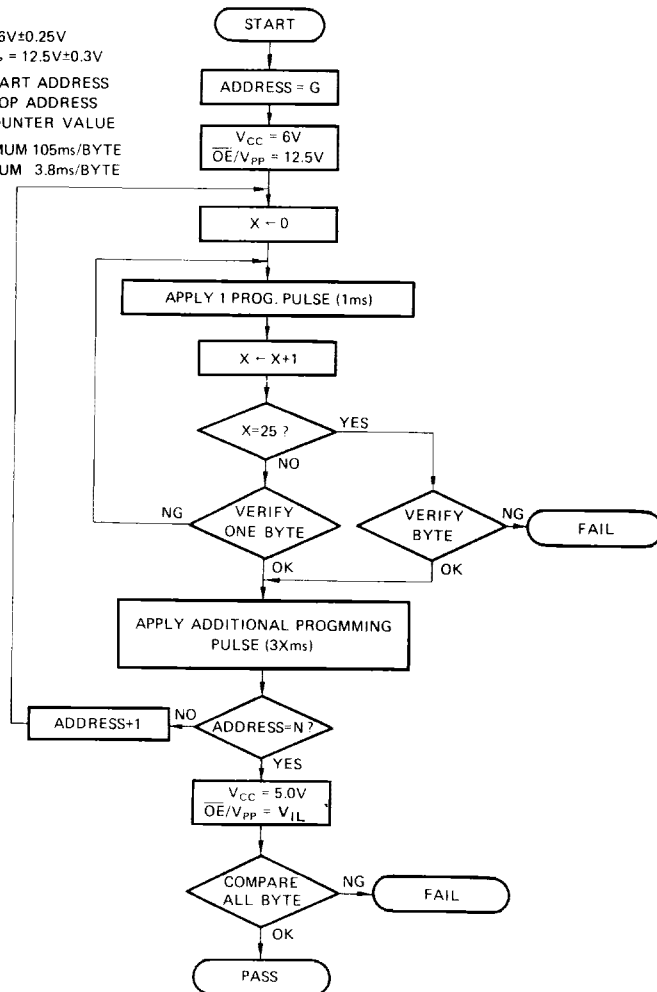
AC CHARACTERISTICS

($T_A = 25 \pm 5^\circ\text{C}$, $V_{CC} = 6\text{V} \pm 0.25\text{V}$, $V_{PP} = 12.5\text{V} \pm 0.3\text{V}$)

Parameter	Symbol	Value			Unit
		Min	Typ	Max	
Address Setup Time	t_{AS}	2			μs
Chip Enable Setup Time	t_{CES}	2			μs
Output Enable Setup Time	t_{OES}	2			μs
Data Setup Time	t_{DS}	2			μs
V_{CC} Setup Time	t_{VS}	2			μs
Address Hold Time	t_{AH}	2			μs
Data Hold Time	t_{DH}	2			μs
Output Enable Hold Time	t_{OEh}	2			μs
V_{PP} Recovery Time	t_{VR}	2			μs
Chip Enable to Data Valid	t_{DV}			1	μs
Output Disable to Output Float Delay	t_{DF}	0		130	ns
V_{PP} Program Pulse Rise Time	t_{PRT}	50			ns
Programming Pulse Width	t_{PW}	0.95	1	1.05	ms
Additional Programming Pulse Width	t_{APW}	2.85		78.75	ms

PROGRAMMING FLOW CHART

$V_{CC} = 6V \pm 0.25V$
 $\overline{OE}/V_{PP} = 12.5V \pm 0.3V$
 G : START ADDRESS
 N : STOP ADDRESS
 X : COUNTER VALUE
 MAXIMUM 105ms/BYTE
 MINIMUM 3.8ms/BYTE



Standard 32-pad Ceramic LCC (Suffix: -TV)

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